

Vishay Siliconix

RoHS

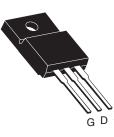
COMPLIANT

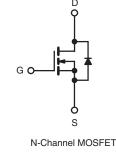


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	400				
R _{DS(on)} (Ω)	V _{GS} = 10 V	1.8			
Q _g (Max.) (nC)	20				
Q _{gs} (nC)	3.3				
Q _{gd} (nC)	11				
Configuration	Single				

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI720GPbF
	SiHFI720G-E3
SnPb	IRFI720G
	SiHFI720G

ABSOLUTE MAXIMUM RATINGS $T_{C} = 25 \text{ °C}$, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	400	V		
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C		2.6		
	V _{GS} at 10 V	$T_C = 100 \ ^{\circ}C$		1.7	А	
Pulsed Drain Current ^a			I _{DM}	10		
Linear Derating Factor			0.24	W/°C		
Single Pulse Avalanche Energy ^b		E _{AS}	150	mJ		
Repetitive Avalanche Current ^a			I _{AR}	2.6	А	
Repetitive Avalanche Energy ^a			E _{AR}	3.0	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	P _D 30		
Peak Diode Recovery dV/dtc		dV/dt	4.0	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	U	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 38 mH, $R_G = 25 \Omega$, $I_{AS} = 2.6$ A (see fig. 12).

c. $I_{SD} \le 3.3$ A, $dI/dt \le 65$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 65						
Maximum Junction-to-Case (Drain)	R _{thJC}	- 4.1				°C/W		
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,					1	1	1	1
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static		T			1		1	1
Drain-Source Breakdown Voltage	V _{DS}		= 0 V, I _D = 2		400	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I _D = 1 mA	-	0.51	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V_{GS} , $I_D = 2$	250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	Ň	$V_{GS} = \pm 20 V$			-	± 100	nA
Zero Gate Voltage Drain Current	laaa	V _{DS} =	400 V, V _G	s = 0 V	-	-	25	μA
Zero Gale Voltage Drain Gurrent	I _{DSS}	V _{DS} = 320 V	, V _{GS} = 0 V	, T _J = 125 °C	-	-	250	μΛ
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D	= 1.6 A ^b	-	-	1.8	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	1.6 A ^b	1.5	-	-	S
Dynamic		•						
Input Capacitance	C _{iss}		$V_{GS} = 0 V,$		-	410	-	
Output Capacitance	Coss		$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	120	-	1_
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	47	-	pF	
Drain to Sink Capacitance	С		f = 1.0 MHz	2	-	12	-	1
Total Gate Charge	Qg				-	-	20	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_{\rm D} = 3.3$ Å	A, $V_{DS} = 320 V$,	-	-	3.3	nC
Gate-Drain Charge	Q _{gd}	1	see no	g. 6 and 13 ^b	-	-	11	
Turn-On Delay Time	t _{d(on)}				-	10	-	
Rise Time	t _r		200 V, I _D =		-	14	-	
Turn-Off Delay Time	t _{d(off)}	R _G = 18 Ω, R _D = 56 Ω, see fig. 10 ^b			-	30	-	ns
Fall Time	t _f		See lig. 10		_	13	_	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	Ls			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s				1		1	1
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.6	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	10		
Body Diode Voltage	V_{SD}	T _J = 25 °C,	$T_J = 25 \ ^{\circ}C, \ I_S = 2.6 \ A, \ V_{GS} = 0 \ V^b$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = 3.3 \text{ A}, dI/dt = 100 \text{ A}/\mu s^{b}$		-	300	600	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.5	3.0	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time i	s negligible (turn	-on is dor	ninated by	, L _S and I	_D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

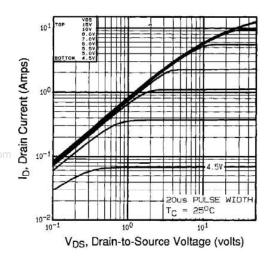


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

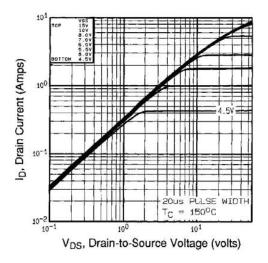


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

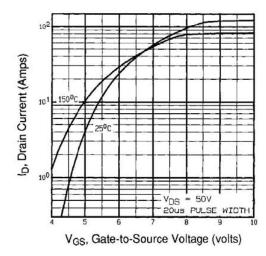


Fig. 3 - Typical Transfer Characteristics

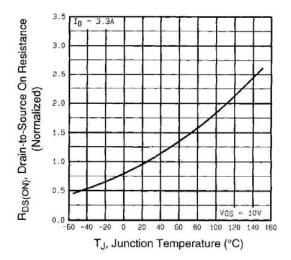


Fig. 4 - Normalized On-Resistance vs. Temperature

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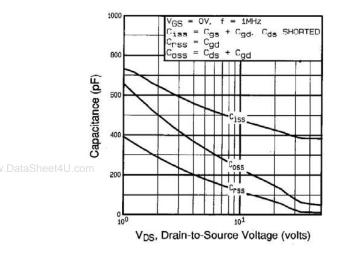


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

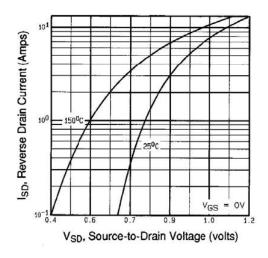


Fig. 7 - Typical Source-Drain Diode Forward Voltage

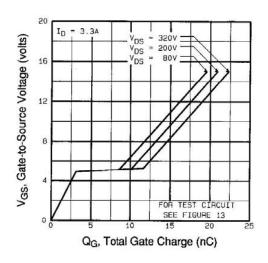


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

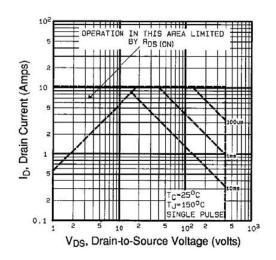


Fig. 8 - Maximum Safe Operating Area

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IRFI720G, SiHFI720G

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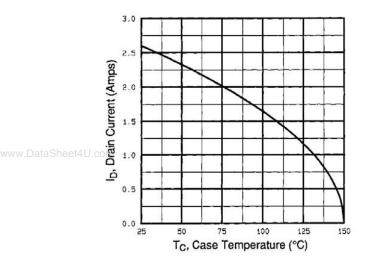


Fig. 9 - Maximum Drain Current vs. Case Temperature

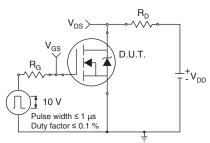


Fig. 10a - Switching Time Test Circuit

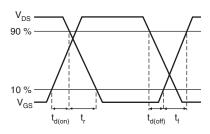
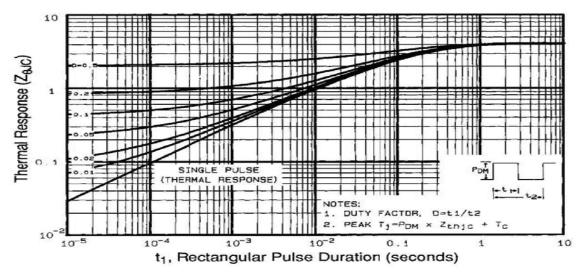


Fig. 10b - Switching Time Waveforms





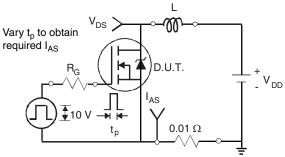


Fig. 12a - Unclamped Inductive Test Circuit

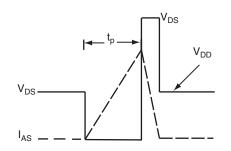
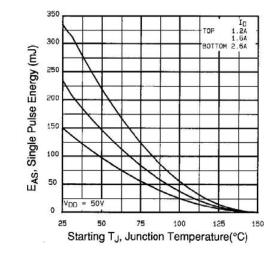


Fig. 12b - Unclamped Inductive Waveforms

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Fig. 12c - Maximum Avalanche Energy vs. Drain Current

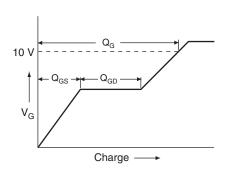
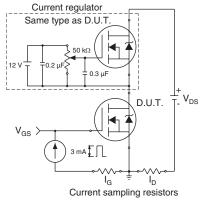
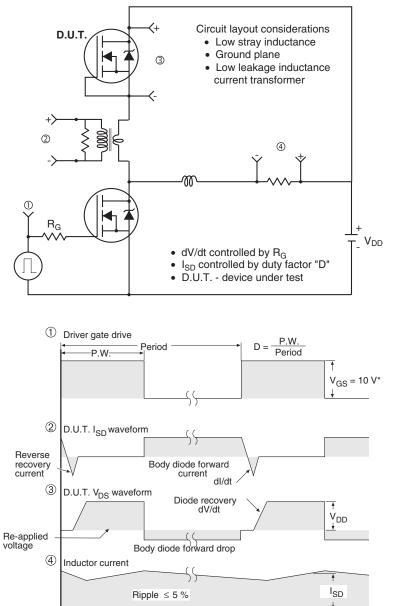


Fig. 13a - Basic Gate Charge Waveform





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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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